Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/688,264	CERN, YEHUDA	
Examiner	Art Unit	

Dean O. Takaoka

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	SEARCHED				
Class	Subclass	Date	Examiner		
333	12	. 5/14/2005	DT		
333	175	5/14/2005	DT		
333	177	5/14/2005	DT		
333	181	5/14/2005	DT		
333	185	5/14/2005	DT		
307	147	10/3/2005	DT		
336	175	10/3/2005	DT		
340	310.17	10/3/2005	DT		
updated	above	10/3/2005	DT		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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all a	bove	10/3/2005	DT	

SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	)
	DATE	EXMR
PCT/US03/33081	5/14/2004	DT
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